



Sheet 1 of 2

|   |   |  |                                      |
|---|---|--|--------------------------------------|
| <b>Form PTO-1449 Modified</b><br><br>List of Patent and Publications<br>Cited by Applicant<br>(Use several sheets if necessary)<br><br>U.S. Department of Commerce<br>Patent and Trademark Office |   | Docket No.<br><b>MSFT-1736/302204.1</b>  | Application No.<br><b>10/607,087</b> |
|   |   | Applicant<br><b>Richard Tkachuk, et al.</b>  |                                      |
|   |   | Filing Date<br><b>June 26, 2003</b>  | Group<br><b>2161</b>                 |
|   |   | Confirmation No.<br><b>5373</b>  |                                      |
| <b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>   |   |  |                                      |
| <i>fw</i>   | 6 | Han, J. et al., "Data Mining: Concepts and Techniques", <i>Data Mining: Concepts and Techniques</i> , 2001, 5-15, 23, 45, XP-002332057 |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
|   |   |  |                                      |
| <b>EXAMINER</b> <i>Paul J. H.</i>   |   | <b>DATE CONSIDERED</b> <i>May 12, 2006</i>   |                                      |

**Form PTO-1449 Modified**

List of Patent and Publications  
Cited by Applicant  
(Use several sheets if necessary)

U.S. Department of Commerce  
Patent and Trademark Office

Docket No.  
**MSFT-1736/302204.1**

Application No.  
**10/607,087**

Applicant  
**Richard Tkachuk, et al.**

Filing Date  
**June 26, 2003**

Group  
**2161**

Confirmation No.  
**5373**

**U. S. PATENT DOCUMENTS**

| Examiner<br>Initial |   | Document<br>No. | Date     | Name                  | Class | Subclass |
|---------------------|---|-----------------|----------|-----------------------|-------|----------|
| <i>ylm</i>          | 7 | 6,477,536 B1    | 11/05/02 | Pasumansky, M. et al. | 707   | 102      |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |
|                     |   |                 |          |                       |       |          |

**FOREIGN PATENT DOCUMENTS**

| Examiner<br>Initial |  | Document No. | Date | Country | Translation |    |
|---------------------|--|--------------|------|---------|-------------|----|
|                     |  |              |      |         | YES         | NO |
|                     |  |              |      |         |             |    |
|                     |  |              |      |         |             |    |
|                     |  |              |      |         |             |    |
|                     |  |              |      |         |             |    |
|                     |  |              |      |         |             |    |
|                     |  |              |      |         |             |    |

**EXAMINER***Paul P.***DATE CONSIDERED***May 12, 2006*